

High Voltage IGBT

IXGH 25N160
IXGT 25N160

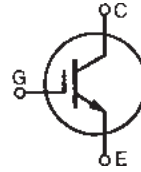
$$V_{CES} = 1600 \text{ V}$$

$$I_{C25} = 75 \text{ A}$$

$$V_{CE(sat)} = 2.5 \text{ V}$$

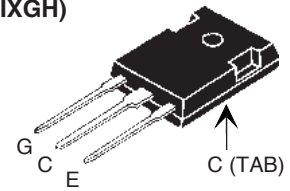
For Capacitor Discharge Applications

Preliminary Data Sheet

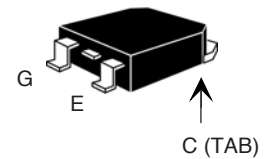


| Symbol | Test Conditions | Maximum Ratings | |
|---|--|-----------------------------------|------------------|
| V_{CES} | $T_J = 25^\circ\text{C to } 150^\circ\text{C}$ | 1600 | V |
| V_{CGR} | $T_J = 25^\circ\text{C to } 150^\circ\text{C}; R_{GE} = 1 \text{ M}\Omega$ | 1600 | V |
| V_{GES} | Continuous | ± 20 | V |
| V_{GEM} | Transient | ± 30 | V |
| I_{C25} | $T_C = 25^\circ\text{C}$ | 75 | A |
| I_{C110} | $T_C = 110^\circ\text{C}$ | 25 | A |
| I_{CM} | $T_C = 25^\circ\text{C}, V_{GE} = 20 \text{ V}, 1 \text{ ms}$ | 200 | A |
| SSOA (RBSOA) | $V_{GE} = 15 \text{ V}, T_{VJ} = 125^\circ\text{C}, R_G = 20 \Omega$ Clamped inductive load | $I_{CM} = 100$ @ $0.8 V_{CES}$ | A |
| P_C | $T_C = 25^\circ\text{C}$ | 300 | W |
| T_J | | -55 ... +150 | $^\circ\text{C}$ |
| T_{JM} | | 150 | $^\circ\text{C}$ |
| T_{stg} | | -55 ... +150 | $^\circ\text{C}$ |
| Maximum Lead temperature for soldering 1.6 mm (0.062 in.) from case for 10 s | | 300 | $^\circ\text{C}$ |
| Maximum Tab temperature for soldering SMD devices for 10 s | | 260 | $^\circ\text{C}$ |
| M_d | Mounting torque (TO-247) | 1.13/10 | Nm/lb-in |
| Weight | | TO-247 | 6 g |
| | | TO-268 | 4 g |

TO-247 (IXGH)



TO-268 (IXGT)



G = Gate, C = Collector,
E = Emitter, TAB = Collector

Features

- High peak current capability
- Low saturation voltage
- MOS Gate turn-on -drive simplicity
- Rugged NPT structure
- International standard packages
 - JEDEC TO-268 and
 - JEDEC TO-247 AD
- Molding epoxies meet UL 94 V-0 flammability classification

Applications

- Capacitor discharge
- Pulser circuits

Advantages

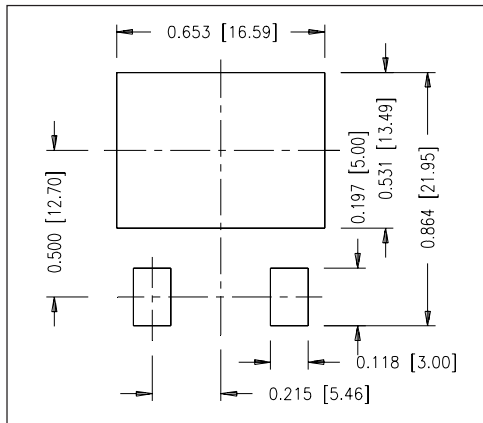
- High power density
- Suitable for surface mounting
- Easy to mount with 1 screw, (isolated mounting screw hole)

| Symbol | Test Conditions | Characteristic Values ($T_J = 25^\circ\text{C}$ unless otherwise specified) | | |
|---------------|---|---|------|--------------------------|
| | | min. | typ. | max. |
| BV_{CES} | $I_C = 250 \mu\text{A}, V_{GE} = 0 \text{ V}$ | 1600 | | V |
| $V_{GE(th)}$ | $I_C = 250 \mu\text{A}, V_{CE} = V_{GE}$ | 3.0 | | V |
| I_{CES} | $V_{CE} = 0.8 \cdot V_{CES}$ $V_{GE} = 0 \text{ V}$ $T_J = 125^\circ\text{C}$ | | | 50 μA 1 mA |
| I_{GES} | $V_{CE} = 0 \text{ V}, V_{GE} = \pm 30 \text{ V}$ | | | $\pm 100 \text{ nA}$ |
| $V_{CE(sat)}$ | $I_C = I_{C110}, V_{GE} = 15 \text{ V}$ | | | 2.5 V |
| | $I_C = 100 \text{ A}, V_{GE} = 20 \text{ V}$ | | | 4.7 V |

| Symbol | Test Conditions | Characteristic Values ($T_J = 25^\circ\text{C}$ unless otherwise specified) | | |
|--------------|---|---|------|----------|
| | | min. | typ. | max. |
| g_{fs} | $I_C = 50\text{ A}; V_{CE} = 10\text{ V}$, Note 1 | 14 | 21 | S |
| $I_{C(ON)}$ | $V_{GE} = 15\text{ V}, V_{CE} = 10\text{ V}$, Note 1 | | 200 | A |
| C_{ies} | $V_{CE} = 25\text{ V}, V_{GE} = 0\text{ V}, f = 1\text{ MHz}$ | | 2090 | pF |
| C_{oes} | | | 94 | pF |
| C_{res} | | | 34 | pF |
| Q_g | $I_C = 50\text{ A}, V_{GE} = 15\text{ V}, V_{CE} = 0.5 V_{CES}$ | | 84 | nC |
| Q_{ge} | | | 15 | nC |
| Q_{gc} | | | 37 | nC |
| $t_{d(on)}$ | Resistive load | | 47 | ns |
| t_{ri} | $I_C = 100\text{ A}, V_{GE} = 15\text{ V}$, Note 1 | | 236 | ns |
| $t_{d(off)}$ | $V_{CE} = 1200\text{ V}, R_G = 10\ \Omega$ | | 86 | ns |
| t_{fi} | | | 440 | ns |
| R_{thJC} | | | | 0.42 K/W |
| R_{thCK} | (TO-247) | | 0.25 | K/W |

Notes: 1. Pulse test, $t < 300\ \mu\text{s}$, duty cycle $< 2\%$

TO-268: Minimum Recommended Footprint



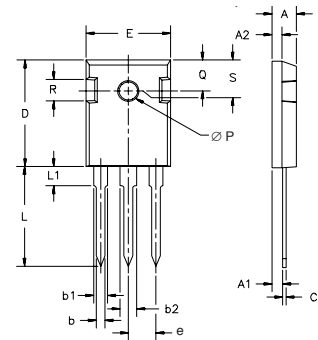
PRELIMINARY TECHNICAL INFORMATION

The product presented herein is under development. The Technical Specifications offered are derived from data gathered during objective characterizations of preliminary engineering lots; but also may yet contain some information supplied during a subjective pre-production design evaluation. IXYS reserves the right to change limits, test conditions, and dimensions without notice.

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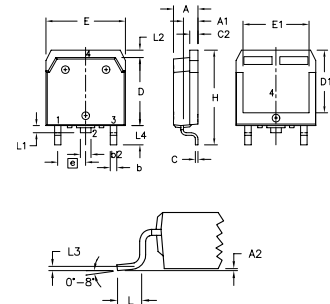
IXYS MOSFETs and IGBTs are covered by 4,835,592 4,931,844 5,049,961 5,237,481 6,162,665 6,404,065 B1 6,683,344 6,727,585
one or more of the following U.S. patents: 4,850,072 5,017,508 5,063,307 5,381,025 6,259,123 B1 6,534,343 6,710,405B2 6,759,692
4,881,106 5,034,796 5,187,117 5,486,715 6,306,728 B1 6,583,505 6,710,463 6771478 B2

TO-247 AD Outline



| Dim. | Millimeter | | Inches | |
|----------------|------------|-------|---------|-------|
| | Min. | Max. | Min. | Max. |
| A | 4.7 | 5.3 | .185 | .209 |
| A ₁ | 2.2 | 2.54 | .087 | .102 |
| A ₂ | 2.2 | 2.6 | .059 | .098 |
| b | 1.0 | 1.4 | .040 | .055 |
| b ₁ | 1.65 | 2.13 | .065 | .084 |
| b ₂ | 2.87 | 3.12 | .113 | .123 |
| C | .4 | .8 | .016 | .031 |
| D | 20.80 | 21.46 | .819 | .845 |
| E | 15.75 | 16.26 | .610 | .640 |
| e | 5.20 | 5.72 | 0.205 | 0.225 |
| L | 19.81 | 20.32 | .780 | .800 |
| L1 | | 4.50 | | .177 |
| ØP | 3.55 | 3.65 | .140 | .144 |
| Q | 5.89 | 6.40 | 0.232 | 0.252 |
| R | 4.32 | 5.49 | .170 | .216 |
| S | | | 242 BSC | |

TO-268 Outline



| Dim. | Millimeter | | Inches | |
|----------------|------------|-------|----------|------|
| | Min. | Max. | Min. | Max. |
| A | 4.9 | 5.1 | .193 | .201 |
| A ₁ | 2.7 | 2.9 | .106 | .114 |
| A ₂ | .02 | .25 | .001 | .010 |
| b | 1.15 | 1.45 | .045 | .057 |
| b ₂ | 1.9 | 2.1 | .75 | .83 |
| C | .4 | .65 | .016 | .026 |
| D | 13.80 | 14.00 | .543 | .551 |
| E | 15.85 | 16.05 | .624 | .632 |
| E ₁ | 13.3 | 13.6 | .524 | .535 |
| e | 5.45 BSC | | .215 BSC | |
| H | 18.70 | 19.10 | .736 | .752 |
| L | 2.40 | 2.70 | .094 | .106 |
| L1 | 1.20 | 1.40 | .047 | .055 |
| L2 | 1.00 | 1.15 | .039 | .045 |
| L3 | 0.25 BSC | | .010 BSC | |
| L4 | 3.80 | 4.10 | .150 | .161 |

Fig. 1. Output Characteristics @ 25°C

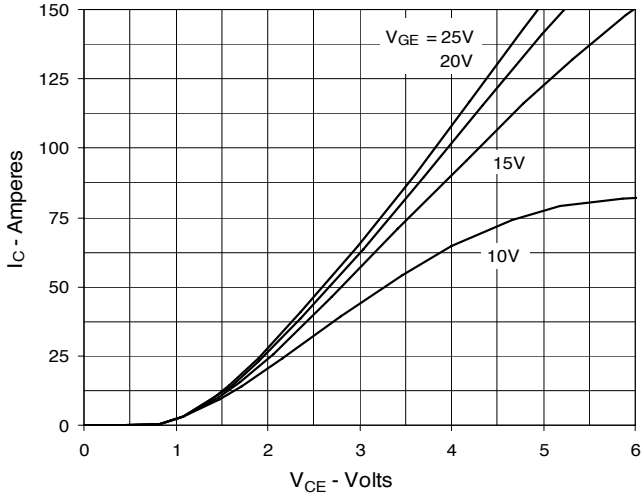


Fig. 2. Extended Output Characteristics @ 25°C

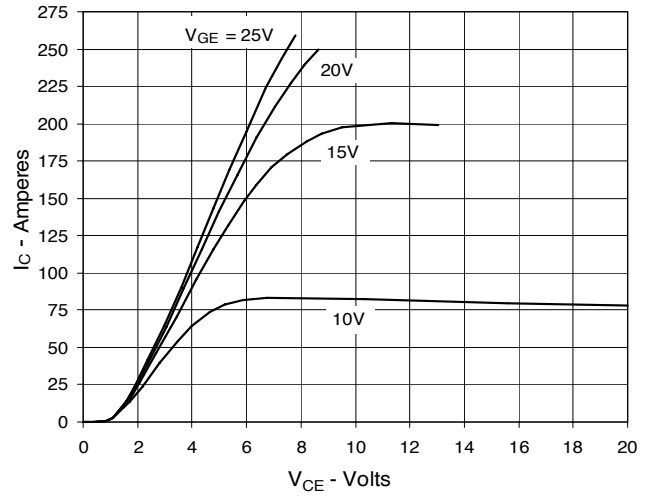


Fig. 3. Output Characteristics @ 125°C

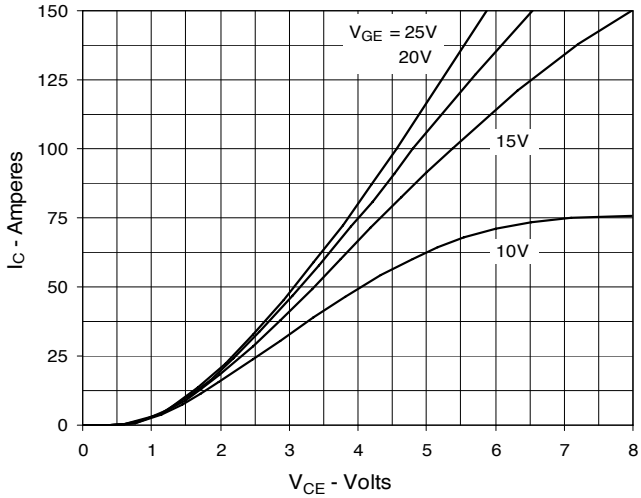


Fig. 4. Dependence of $V_{CE(sat)}$ on Junction Temperature

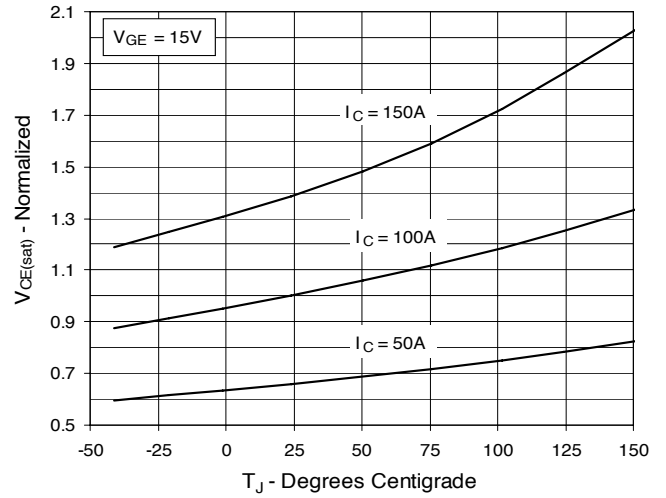


Fig. 5. Collector-to-Emitter Voltage vs. Gate-to-Emitter Voltage

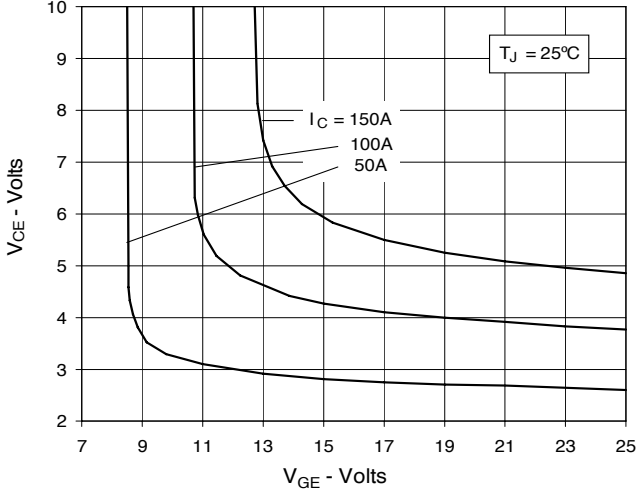


Fig. 6. Input Admittance

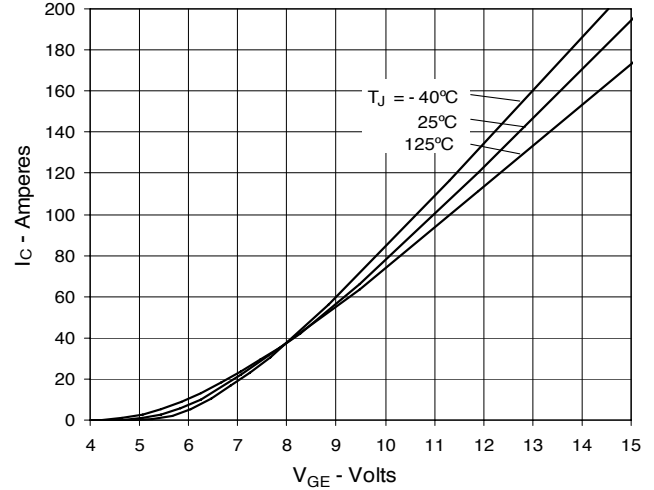


Fig. 7. Transconductance

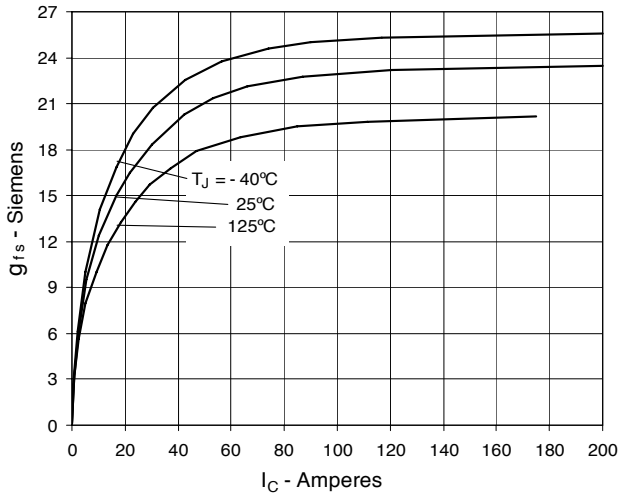


Fig. 8. Resistive Turn-On Rise Time vs. Junction Temperature

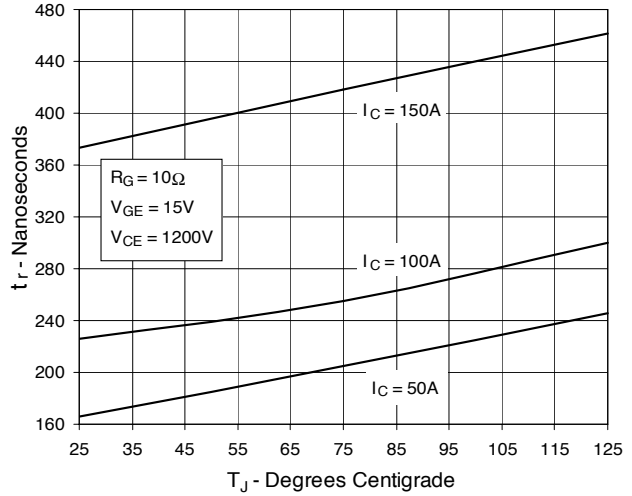


Fig. 9. Resistive Turn-On Rise Time vs. Collector Current

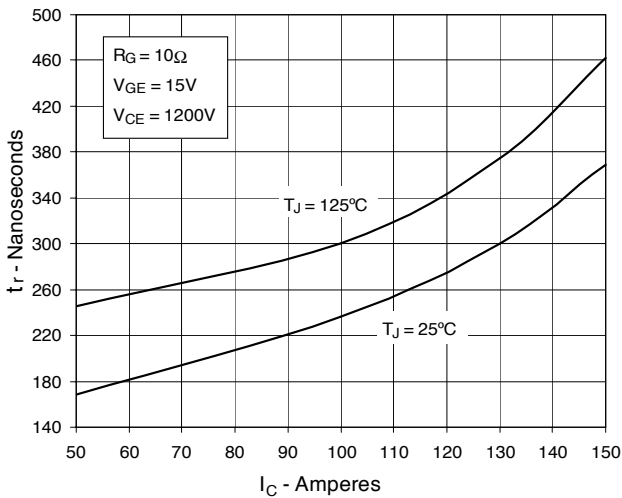


Fig. 10. Resistive Turn-On Switching Times vs. Gate Resistance

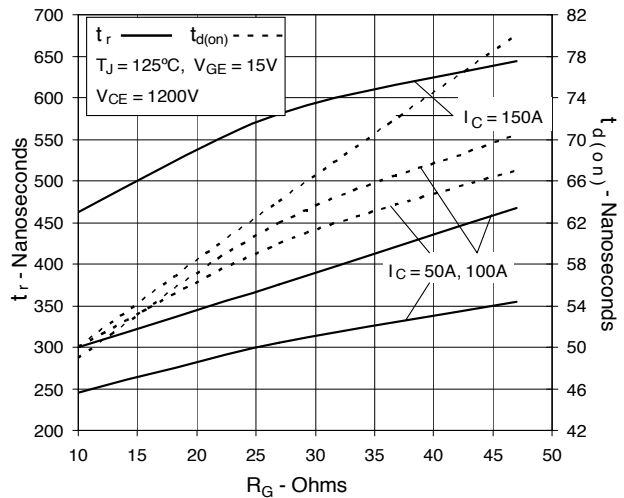


Fig. 11. Resistive Turn-Off Switching Times vs. Junction Temperature

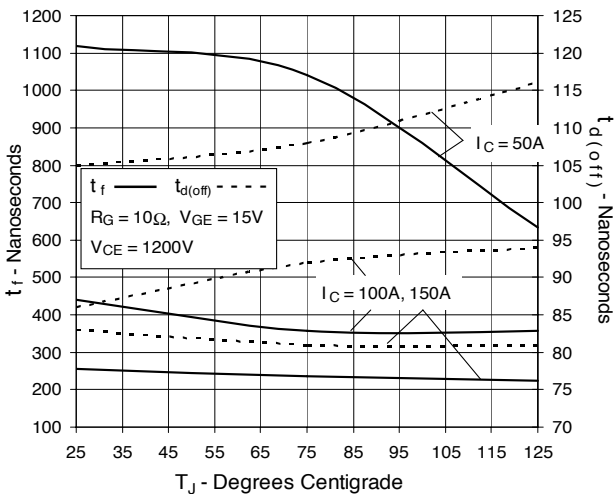


Fig. 12. Resistive Turn-Off Switching Times vs. Collector Current

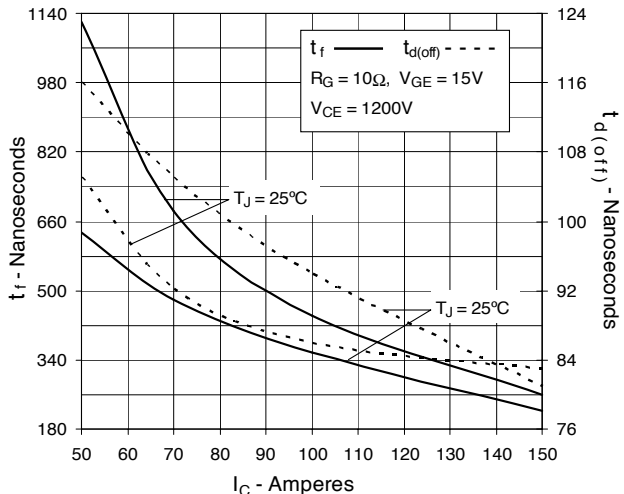


Fig. 13. Resistive Turn-Off Switching Times vs. Gate Resistance

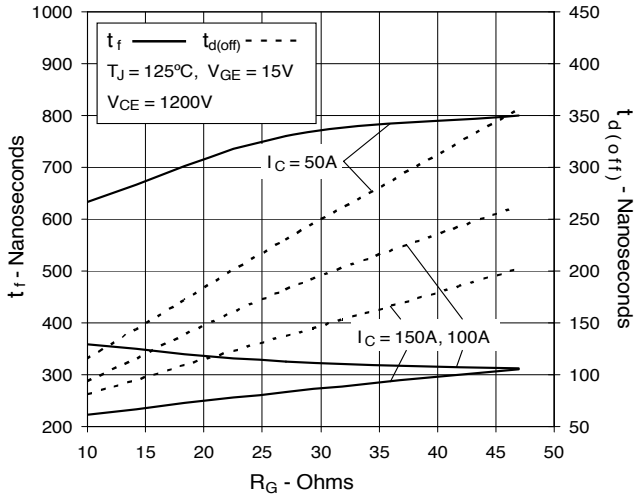


Fig. 14. Gate Charge

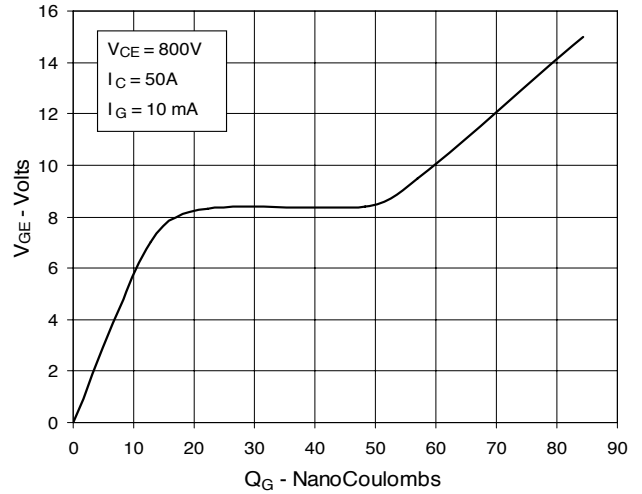


Fig. 15. Reverse-Bias Safe Operating Area

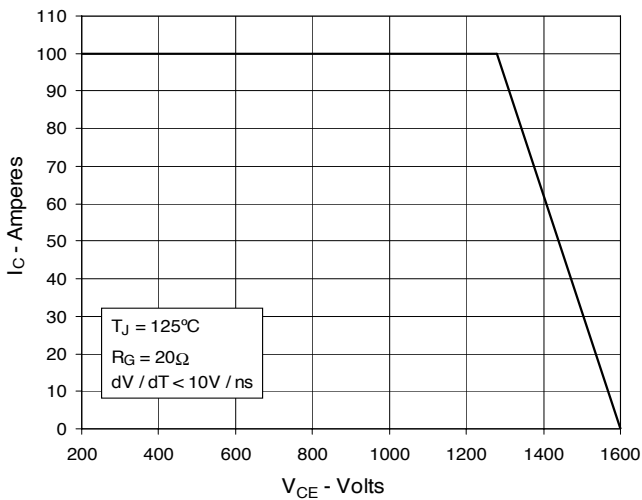


Fig. 16. Capacitance

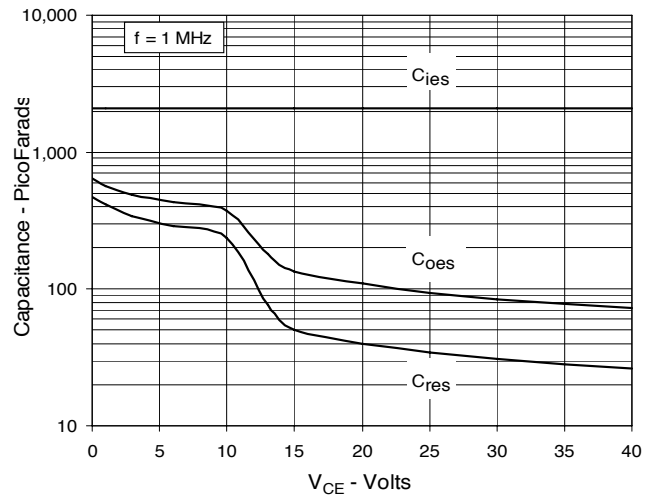
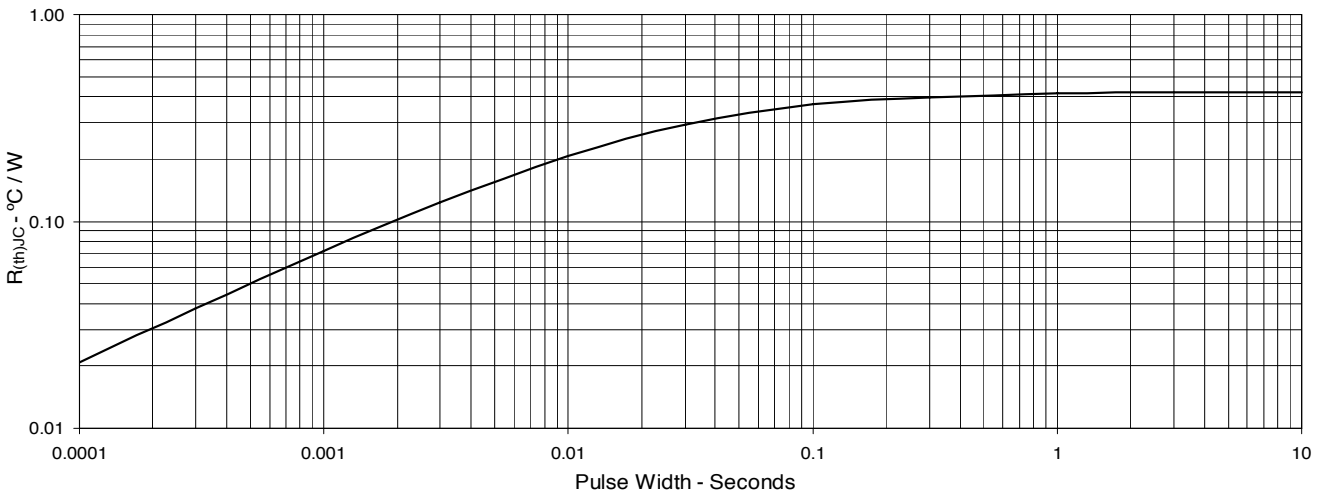


Fig. 17. Maximum Transient Thermal Resistance





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